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SI.	Quantity Measured / Instrument	Range/Frequency	*Calibration Measurement Capability (±)	Remarks			
	ELECTRO TECHNICAL CALIBRATION						
	MEASURE						
1.	Voltage Dips & interrup	tion [#]					
	a) Generator Output Voltage at NO Load	0 to 100%		Using Oscilloscope with HV probe and Digital Multimeter as per IEC 61000-4-11 Ed 2.0			
	b) Dips/ interruption Time	10 ms to 5 s		Using Oscilloscope with HV probe as per IEC 61000-4-11 Ed 2.0			
2.	Combination Wave Sur	ge Test [#]	<i>k</i>				
	Voltage Amplitude	±0.5 kV to ±8.0 kV		Using Oscilloscope and HV Differential Probe as			
	Voltage Front Time	1.2 μs ±30% 10 μs ±30%	7.8% 2.28%	per IEC 61000-4-5 Ed 3.0			
	Voltage Pulse Duration	50 μs ±20% 700 μs ±20%	3.10% 1.10%				
	Current Amplitude	±0.25kA to ±4kA ±12.5A to ±200 A		Using Oscilloscope and Current Clamp as per IEC 61000-4-5 Ed 3.0			
	Current Front Time	8 μs ±20% 5 μs ±20%	3.12% 3.48%				
	Current Pulse Width	20 µs ±20% 320 µs ±20%	3.41% 1.0%				

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SI.	Quantity Measured / Instrument	Range/Frequency	*Calibration Measuremen Capability (±)	t Remarks
3.	Ring Wave Generator	12 Ω and 30 Ω [#]		I
	Voltage Rise Time (Open Circuit)	0.5µs ±30%	1.0%	Using CRO and HV Differential Probe as per IEC 61000-4-12
	Current Rise Time (Short Circuit)	0.2 µs to 1.0 µs	1.0%	Using CRO and Current Probe as per IEC 61000-4-12
	Frequency	100 kHz ±10%	2.11%	Using CRO and HV
	Decay in Voltage	0.4 < Ratio of Pk2 to Pk1 < 1.1 0.4 < Ratio of Pk3 to Pk2 < 0.8 0.4 < Ratio of Pk4 to Pk3 < 0.8	4.42%	Differential Probe as per IEC 61000-4-12
	Repetition rate	1/ min or faster	2.0%	
	Open Circuit Voltage	250 V to 6 kV ±10%	3.05%	
	Short Circuit Current	20.8 A to 500 A ±10% @ 12 Ω 8.3 A to 200 A ±10% @ 30 Ω	2.58%	Using CRO and Current Probe as per IEC 61000-4-12
4.	Electrical Fast Transie	ent Test System, With Cdr	And Capacitive Coupling	Clamp [#]
	Pulse Amplitude	±0.25 kV to ±5.0 kV ±10%	3.29%	Using CRO & Dividers (50Ω & 1000 Ω)
	Pulse Rise Time	5 ±1.5 ns	3.93%	as per IEC 61000-4-4
	Pulse Width	50 ± 15 ns	2.44%	
	Repetition Frequency	5 kHz ± 20 %, 100 kHz ± 20 %, 1MHz ± 20 %	1.0%	
	Burst Duration	15 ± 3 ms	1.0%	
	Burst Period	300 ± 60 ms	1.0%	
	Pulse Amplitude in 1000Ω	±0.25 kV to ±5.0 kV ± 20%	3.29%	

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	Pulse Width in 1000Ω	50ns (-15 ns to +100 ns)	2.44%	
	Pulse Amplitude Capacitive coupling Clamp	2.0 kV ±200V	3.29%	
	Peak voltage -CDN	±0.25 kV to ±5.0 kV ± 10%	3.29%	
	Pulse Width-CDN	(45 ± 15) ns.	2.44%	
	Pulse Rise Time-CDN	(5.5 ± 1.5) ns	3.93%	
5.	Electrostatic Discharge	Generator ^{\$}		
	Contact Discharge			
	First Peak Current	±7.5 A to ±112.5 A (±15 %) (± 2 kV to ± 30 kV)		Using CRO & ESD Target Attenuator Cable Chain as per IEC 61000-4-2
	Rise Time	0.8 ns ± 25 %	8.21%	
	Current at 30 ns	±4.0A to ±60 A (±2 kV to ±30 kV)	3.79%	
	Current at 60 ns	±2.0 A to ±30 A (± 2 kV to ± 30 kV)	3.79%	
	Air Discharge			
	Generator DC output voltage	±2 kV to ±30 kV (±5%)		Using DMM with Divider as per IEC 61000-4-2
6.	Target – Attenuator Cal	ble Chain [®]		
	Low Frequency Transfer Impedance	0.02 Ω to 0.2 Ω ±1%		Using DMM or VNA as per IEC 61000-4-2
	DC Resistance	< 2.1 Ω		Using DMM as per IEC 61000-4-2
7.	Impedance ^{\$}			
	Line Impedance Stabilization Network- LISN, Coupling & Decoupling-CDN	9 kHz to 250 MHz 1Ω to 300Ω		Using Vector Network Analyzer by Direct Method as per CISPR 16-1-2: Ed. 2.0 2017-11, CISPR 32

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8.	Phase Angle ^s LISN	9 kHz to 250 MHz (-)90° to +90°	3.1°	Using Vector Network Analyzer by Direct Method as per CISPR 16-1-2, CISPR 32
9.	Power Frequency Magn	etic Field Immunity [#]	I	
	Current : Continuous & Short Duration- 1s to 3s, Current Values Standard Coil:1 m X 1m,1mX2.6m	1 A/m to 1000 A/m ±2.0%	2%	Using Current clamp with DMM and Clamp on Meter As per IEC 61000-4-8
10.	Impulse Magnetic Field	±	I	
	Short Circuit Peak Current	100 A to 1000 A ±10 %	2.38%	Using CRO & Current Probe
	Current Front Time:	8 μs ± 20 %	2.02%	As per IEC 61000-4-9
	Duration	20 µs ± 20 %	1.0%	
11.	Frequency ^s	9kHz to 15 GHz	1.17ppm	Using Vector Network Analyzer By Direct Method
12.	RF Parameters ^{\$}	_ <u>_</u>	I	
	Attenuation, Voltage Division Factor / Coupling Decoupling	9 kHz to 15GHz 0.1 dB to 70 dB	0.4 dB	Using Vector Network Analyzer By Direct Method
	Factor/Isolation, Insertion loss/ Bulk Current Injection, Directional Coupler, Attenuator, Adapter LISN, Impedance Stabilization Network , ESD Target, Resistive HV Dividers, EM Clamp, Cable	9 kHz to 3.2 GHz 0.1 dB to 70 dB	0.25 dB	Using Signal Generator and Power meter By Direct Method

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SI.	Quantity Measured / Instrument	Range/Frequency	*Calibration Measurement Capability (±)	Remarks

13.	RF Power Amplifier ^s					
	Gain	9 kHz to 6 GHz 5 dB to 65 dB	0.4 dB to 0.56 dB	Using Signal Generator, Power Meter By Direct Method		
	Harmonics Level	9 kHz to15GHz 5 dBc to 80 dBc	0.52dB to 0.7 dB	Using Vector Network Analyzer With Spectrum By Direct Method		
	Power Measurement	9kHz to 6GHz +15dBm to -60dBm	0.38 dB to 0.56 dB	Using Signal Generator Power Sensor By Direct Method		
		9kHz to 6GHz +60dBm	0.56 dB	Using Signal Generator Power Sensor with Attenuator By Direct Method		
14.	Amplitude Modulation ^{\$}	9kHz to 3.2 GHz 10% to 90%	3.30%	Using CRO By Direct Method		
		3.2 GHz to 15 GHz 10% to 90%	4.20%	Using Vector Network Analyzer With Spectrum By Direct Method		

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SI.	Quantity Measured / Instrument	Range/Frequency	*Calibration Measureme Capability (±)	nt Remarks
15.	Return Loss (VSWR)/ Attenuator, Antenna, Amplifier, Termination, RF Load, Directional Coupler, Adapter Line	9 kHz to 15GHz 1 dB to 46 dB	0.40dB	Using Vector Network Analyzer By Direct Method
		9 kHz to 3.2 GHz 1 to 46 dB	0.35dB	Using Signal Generator , Power meter / Vector Network Analyzer With Spectrum & Directional Coupler By Direct Method
16.	Antenna Factor (Antenna) ^{\$}			
	2M Loop Antenna, Monopole/ ROD Antenna	9 kHz to 30 MHz	1.0 dB	Using Signal Generator, Vector Network Analyzer With Spectrum as per CISPR 16-1-4
17.	Transfer Impedance – RF Current Clamp ^{\$}	10 kHz to 500 MHz	0.4dB	Using Vector Network Analyzer By Direct Method
II.	SOURCE			
1.	Frequency [#]	20 Hz to 3.2GHz	3.1 ppm to 1.16ppm	Using Signal Generator by Direct Method
2.	Power Measurement [#]	9kHz to 3.2GHz +15dBm to -60dBm	0.25 dB to 0.35 dB	Using Signal Generator and Power Sensor by Comparison method

* Measurement Capability is expressed as an uncertainty (±) at a confidence probability of 95% ^{\$} Only in Permanent Laboratory [#] The laboratory is also capable for site calibration however, the uncertainty at site depends on the

prevailing actual environmental conditions and master equipment used.